

TLE2037, TLE2037A, TLE2037Y EXCALIBUR LOW-NOISE HIGH-SPEED PRECISION DECOMPENSATED OPERATIONAL AMPLIFIERS

SLOS055C – MAY 1990 – REVISED AUGUST 1994

- **Outstanding Combination of DC Precision and AC Performance:**
Gain-Bandwidth Product . . . 50 MHz Typ
 $V_n \dots 3.3 \text{ nV}/\sqrt{\text{Hz}}$ at $f = 10 \text{ Hz Typ}$,
 $2.5 \text{ nV}/\sqrt{\text{Hz}}$ at $f = 1 \text{ kHz Typ}$
 $V_{IO} \dots 25 \mu\text{V Max}$ at $T_A = 25^\circ\text{C}$
 $A_{VD} \dots 45 \text{ V}/\mu\text{V Typ}$ With $R_L = 2 \text{ k}\Omega$,
 $19 \text{ V}/\mu\text{V Typ}$ With $R_L = 600 \Omega$

- Available in Standard-Pinout Small-Outline Package
- Output Features Saturation Recovery Circuitry
- Macromodels and Statistical information Included

description

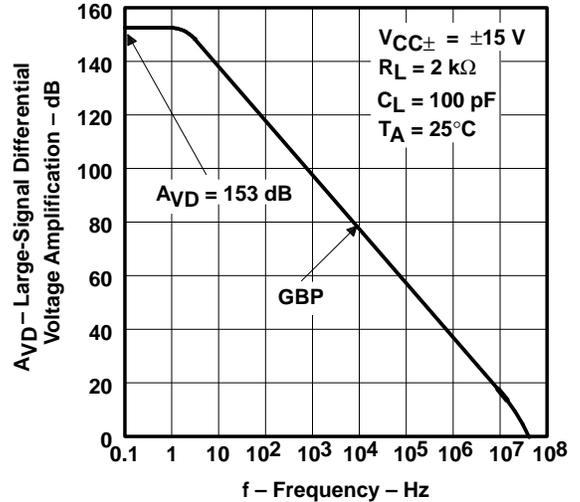
The TLE2037 and TLE2037A combine innovative circuit design expertise and high-quality process control techniques to produce a level of ac performance and dc precision previously unavailable in single operational amplifiers. Using the Texas Instruments state-of-the-art Excalibur process, these devices allow upgrades to systems that use lower-precision devices.

The TLE2037 and TLE2037A are decompensated versions of the TLE2027 and TLE2027A and are stable to a close-loop gain of 5. In the area of dc precision, these parts offer maximum offset voltages of 100 μV and 25 μV , respectively, common-mode rejection ratio of 131 dB (typ), supply voltage rejection ratio of 144 dB (typ), and dc gain of 45 $\text{V}/\mu\text{V}$ (typ).

The ac performance is highlighted by a typical gain-bandwidth product specification of 50 MHz, 50° of phase margin, and noise voltage specifications of 3.3 $\text{nV}/\sqrt{\text{Hz}}$ and 2.5 $\text{nV}/\sqrt{\text{Hz}}$ at frequencies of 10 Hz and 1 kHz, respectively.

Both the TLE2037 and TLE2037A are available in a wide variety of packages, including the industry-standard 8-pin small-outline version for high-density system applications. The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from -40°C to 105°C. The M-suffix devices are characterized for operation over the full military temperature range of -55°C to 125°C.

**LARGE-SIGNAL
DIFFERENTIAL VOLTAGE AMPLIFICATION
VS
FREQUENCY**



AVAILABLE OPTIONS

T _A	V _{IOmax} AT 25°C	PACKAGED DEVICES				CHIP FORM (Y)
		SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	
0°C to 70°C	25 μV 100 μV	TLE2037ACD TLE2037CD	-	-	TLE2037ACP TLE2037CP	TLE2037Y -
-40°C to 105°C	25 μV 100 μV	TLE2037AID TLE2037ID	-	-	TLE2037AIP TLE2037IP	-
-55°C to 125°C	25 μV 100 μV	TLE2037AMD TLE2037MD	TLE2037AMFK TLE2037MFK	TLE2037AMJG TLE2037MJG	TLE2037AMP TLE2037MP	-

The D packages are available taped and reeled. Add R suffix to device type (e.g., TLE2037ACDR). Chips are tested at 25°C.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



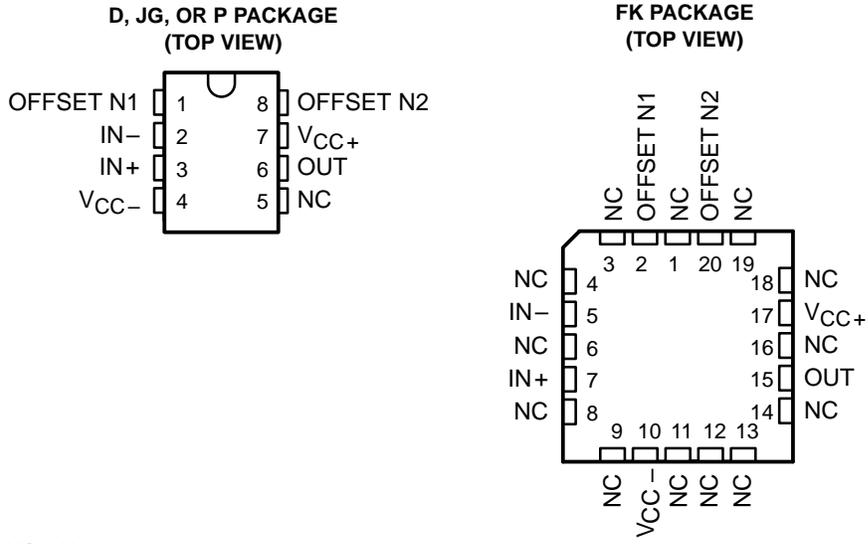
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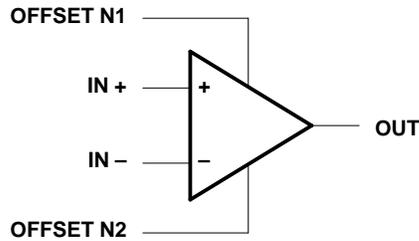
On products compliant to MIL-STD-883, Class B, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

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symbol

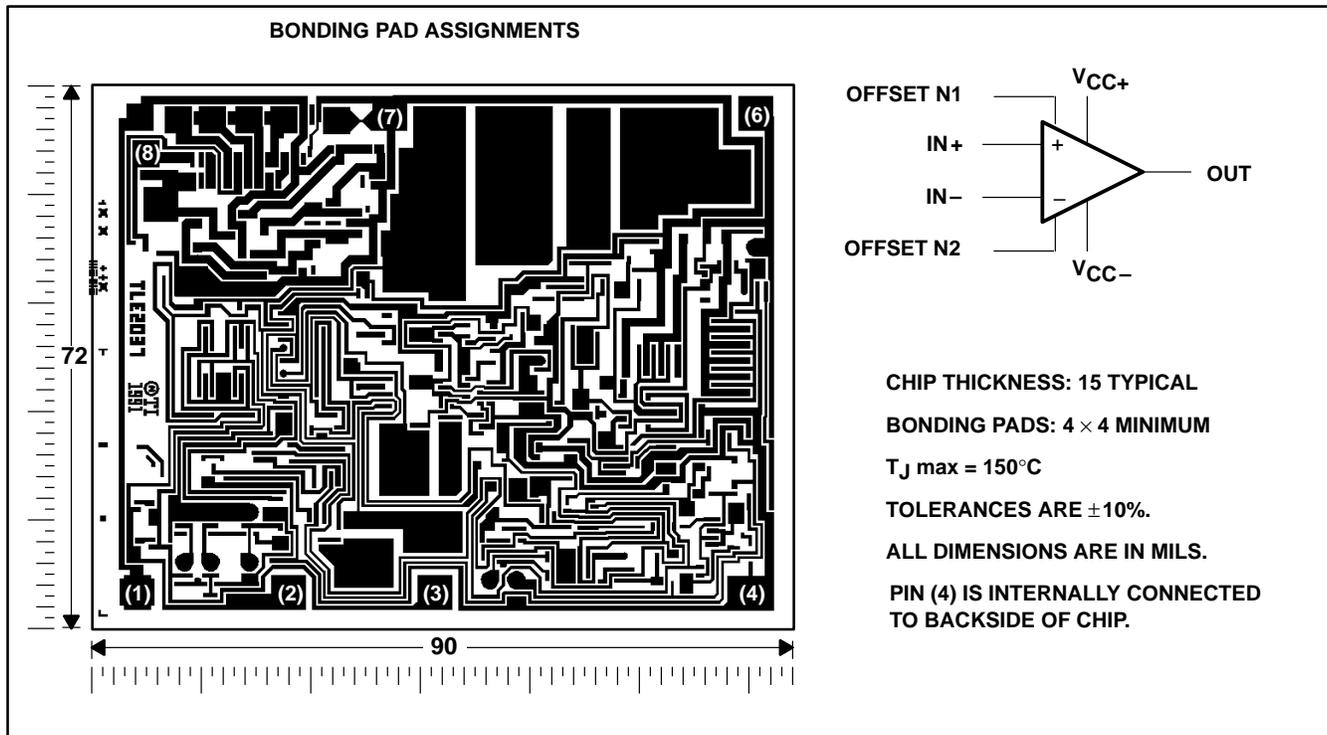


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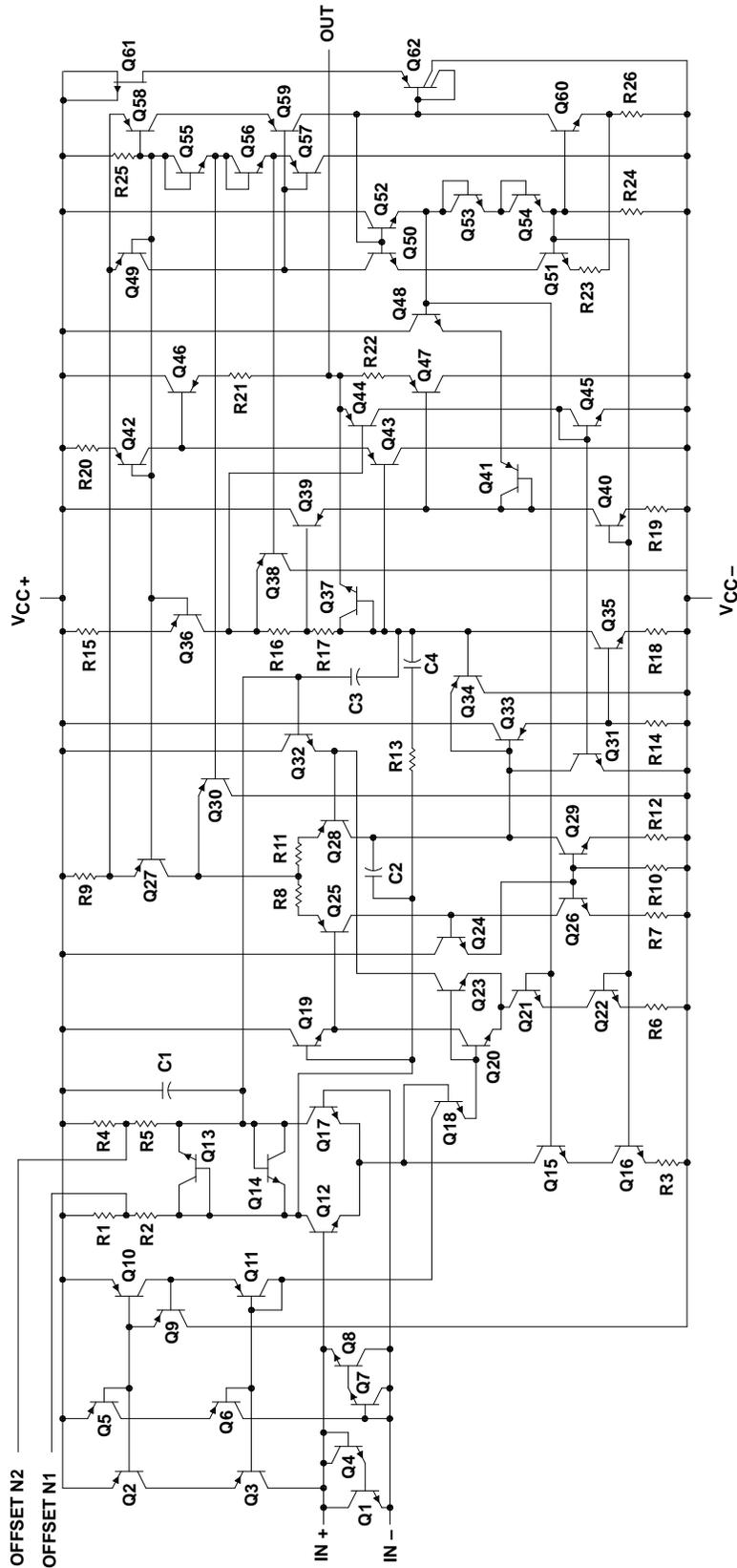
TLE2037 chip information

This chip, when properly assembled, displays characteristics similar to the TLE2037C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



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equivalent schematic



COMPONENT COUNT	
Transistors	61
Resistors	26
Capacitors	4
epi FET	1

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC+} (see Note 1)	19 V
Supply voltage, V_{CC-}	–19 V
Differential input voltage, V_{ID} (see Note 2)	± 1.2 V
Input voltage range, V_I (any input)	$\pm V_{CC}$
Input current, I_I (each input)	± 1 mA
Output current, I_O	± 50 mA
Total current into V_{CC+}	50 mA
Total current out of V_{CC-}	50 mA
Duration of short-circuit current at (or below) 25°C (see Note 3)	unlimited
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A : C suffix	0°C to 70°C
I suffix	–40°C to 105°C
M suffix	–55°C to 125°C
Storage temperature range	–65°C to 150°C
Case temperature for 60 seconds: FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or P package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: JG package	300°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+} and V_{CC-} .
2. Differential voltages are at $IN+$ with respect to $IN-$. Excessive current will flow if a differential input voltage in excess of approximately ± 1.2 V is applied between the inputs unless some limiting resistance is used.
3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$	$T_A = 105^\circ\text{C}$	$T_A = 125^\circ\text{C}$
	POWER RATING		POWER RATING	POWER RATING	POWER RATING
D	725 mW	7.6 mW/°C	464 mW	261 mW	145 mW
FK	1375 mW	11.0 mW/°C	880 mW	495 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	378 mW	210 mW
P	1000 mW	8.0 mW/°C	640 mW	360 mW	200 mW

recommended operating conditions

		C SUFFIX		I SUFFIX		M SUFFIX		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
Supply voltage, $V_{CC\pm}$		± 4	± 19	± 4	± 19	± 4	± 19	V
Common-mode input voltage, V_{IC}	$T_A = 25^\circ\text{C}$	–11	11	–11	11	–11	11	V
	$T_A = \text{Full range}^\dagger$	–10.5	10.5	–10.4	10.4	–10.2	10.2	
Operating free-air temperature, T_A		0	70	–40	105	–55	125	°C

† Full range is 0°C to 70°C for C-suffix devices, –40°C to 105°C for the I-suffix devices, and –55°C to 125°C for the M-suffix devices.



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electrical characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15$ V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLE2037C			TLE2037AC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage		25°C	20	100		10	25	μ V	
		Full range			145		70		
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.4	1		0.2	1	μ V/°C	
Input offset voltage long-term drift (see Note 4)	$V_{IC} = 0, R_S = 50 \Omega$	25°C	0.006	1		0.006	1	μ V/mo	
I_{IO} Input offset current		25°C	6	90		6	90	nA	
		Full range			150		150		
I_{IB} Input bias current		25°C	15	90		15	90	nA	
		Full range			150		150		
V_{ICR} Common-mode input voltage range	$R_S = 50 \Omega$	25°C	-11 to 11	-13 to 13		-11 to 11	-13 to 13	V	
		Full range	-10.5 to 10.5			-10.5 to 10.5			
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600 \Omega$	25°C	10.5	12.9		10.5	12.9	V	
		Full range	10			10			
	$R_L = 2 \text{ k}\Omega$	25°C	12	13.2		12	13.2		
		Full range	11			11			
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600 \Omega$	25°C	-10.5	-13		-10.5	-13	V	
		Full range	-10			-10			
	$R_L = 2 \text{ k}\Omega$	25°C	-12	-13.5		-12	-13.5		
		Full range	11			11			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 11 \text{ V}, R_L = 2 \text{ k}\Omega$	25°C	5	45		10	45	V/ μ V	
		Full range	2			4			
	$V_O = \pm 10 \text{ V}, R_L = 1 \text{ k}\Omega$	25°C	3.5	38		8	38		
		Full range	1			2.5			
	$V_O = \pm 10 \text{ V}, R_L = 600 \text{ k}\Omega$	25°C	2	19		5	19		
		Full range	0.5			2			
c_i Input capacitance		25°C		8		8	pF		
z_o Open-loop output impedance	$I_O = 0$	25°C		50		50	Ω		
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, R_S = 50 \Omega$	25°C	100	131		117	131	dB	
		Full range	98			114			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 4 \text{ V to } \pm 18 \text{ V}, R_S = 50 \Omega$	25°C	94	144		110	144	dB	
		Full range	92			106			
I_{CC} Supply current	$V_O = 0, \text{ No load}$	25°C	3.8	5.3		3.8	4.7	mA	
		Full range			5.6		4.8		

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



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operating characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLE2037C			TLE2037AC			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
SR	Slew rate	$A_{VD} = 5$, $R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, See Figure 1	25°C	6	7.5		6	7.5	$\text{V}/\mu\text{s}$	
			Full range	5			5			
V_n	Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega$, $f = 10\text{ Hz}$	25°C		3.3	8		3.3	4.5	$\text{nV}/\sqrt{\text{Hz}}$
					2.5	4.5		2.5	3.8	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ Hz to }10\text{ Hz}$	25°C		50	250		50	130	nV
I_n	Equivalent input noise current	$f = 10\text{ Hz}$	25°C		1.5	4		1.5	4	$\text{pA}/\sqrt{\text{Hz}}$
		$f = 1\text{ kHz}$			0.4	0.6		0.4	0.6	
THD	Total harmonic distortion	$V_O = \pm 10\text{ V}$, $A_{VD} = 5$, See Note 5	25°C	< 0.002%			< 0.002%			
	Gain-bandwidth product	$f = 100\text{ kHz}$, $R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	35	50		35	50	MHz	
BOM	Maximum output-swing bandwidth	$R_L = 2\text{ k}\Omega$	25°C	80			80			kHz
ϕ_m	Phase margin	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	50°			50°			

† Full range is 0°C to 70°C.

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.

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electrical characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15$ V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLE2037I			TLE2037AI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage		25°C	20		100	10		25	μ V
		Full range	180			105			
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.4		1	0.2		1	μ V/°C
Input bias voltage long-term drift (see Note 4)	$V_{IC} = 0$, $R_S = 50 \Omega$	25°C	0.006		1	0.006		1	μ V/mo
I_{IO} Input offset current		25°C	6		90	6		90	nA
		Full range	150			150			
I_{IB} Input bias current		25°C	15		90	15		90	nA
		Full range	150			150			
V_{ICR} Common-mode input voltage range	$R_S = 50 \Omega$	25°C	-11 to 11	-13 to 13		-11 to 11	-13 to 13		V
		Full range	-10.4 to 10.4			-10.4 to 10.4			
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600 \Omega$	25°C	10.5	12.9		10.5	12.9		V
		Full range	10			10			
	$R_L = 2 \text{ k}\Omega$	25°C	12	13.2		12	13.2		
		Full range	11			11			
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600 \Omega$	25°C	-10.5	-13		-10.5	-13		V
		Full range	-10			-10			
	$R_L = 2 \text{ k}\Omega$	25°C	-12	-13.5		-12	-13.5		
		Full range	-11			-11			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 11$ V, $R_L = 2 \text{ k}\Omega$	25°C	5	45		10	45		V/ μ V
	$V_O = \pm 10$ V, $R_L = 2 \text{ k}\Omega$	Full range	2.5			3.5			
	$V_O = \pm 10$ V, $R_L = 1 \text{ k}\Omega$	25°C	3.5	38		8	38		
	$V_O = \pm 10$ V, $R_L = 1 \text{ k}\Omega$	Full range	1.8			2.2			
	$V_O = \pm 10$ V, $R_L = 600 \Omega$	25°C	2	19		5	19		
	$V_O = \pm 10$ V, $R_L = 600 \Omega$	Full range	0.5			1.1			
c_i Input capacitance		25°C	8			8			pF
z_o Open-loop output impedance	$I_O = 0$	25°C	50			50			Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $R_S = 50 \Omega$	25°C	100	131		117	131		dB
		Full range	96			113			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 4$ V to ± 18 V, $R_S = 50 \Omega$	25°C	94	144		110	144		dB
	$V_{CC\pm} = \pm 4$ V to ± 18 V, $R_S = 50 \Omega$	Full range	90			105			
I_{CC} Supply current	$V_O = 0$, No load	25°C	3.8	5.3		3.8	4.7		mA
		Full range	5.6			4.9			

† Full range is -40°C to 105°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



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operating characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLE2037I			TLE2037AI			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
SR	Slew rate	$A_{VD} = 5$, $R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$, See Figure 1	25°C	6	7.5		6	7.5	V/ μ s	
			Full range	4.7			4.7			
V_n	Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega$, $f = 10\text{ Hz}$	25°C	3.3		8	3.3		nV/ $\sqrt{\text{Hz}}$	
				2.5		4.5	2.5			3.8
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ Hz to }10\text{ Hz}$	25°C	50		250	50		nV	
I_n	Equivalent input noise current	$f = 10\text{ Hz}$	25°C	1.5		4	1.5		pA/ $\sqrt{\text{Hz}}$	
		$f = 1\text{ kHz}$		0.4		0.6	0.4			0.6
THD	Total harmonic distortion	$V_O = \pm 10\text{ V}$, $A_{VD} = 5$, See Note 5	25°C	< 0.002%			< 0.002%			
	Gain-bandwidth product	$f = 100\text{ kHz}$, $R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	35	50		35	50		MHz
B _{OM}	Maximum output-swing bandwidth	$R_L = 2\text{ k}\Omega$	25°C	80			80			kHz
ϕ_m	Phase margin	$R_L = 2\text{ k}\Omega$, $C_L = 100\text{ pF}$	25°C	50°			50°			

† Full range is -40°C to 105°C .

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.

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electrical characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15$ V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A †	TLE2037M			TLE2037AM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50 \Omega$	25°C	20 100		10 25		μV		
		Full range	200		105				
α_{VIO} Temperature coefficient of input offset voltage		Full range	0.4 1*		0.2 1*		$\mu V/^\circ C$		
Input bias voltage long-term drift (see Note 4)		25°C	0.006 1		0.006 1		$\mu V/mo$		
I_{IO} Input offset current		25°C	6 90		6 90		nA		
		Full range	150		150				
I_{IB} Input bias current	25°C	15 90		15 90		nA			
	Full range	150		150					
V_{ICR} Common-mode input voltage range	$R_S = 50 \Omega$	25°C	-11 to 11	-13 to 13	-11 to 11	-13 to 13	V		
		Full range	-10.3 to 10.3		-10.4 to 10.4				
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600 \Omega$	25°C	10.5 12.9		10.5 12.9		V		
		Full range	10		10				
	$R_L = 2 k\Omega$	25°C	12 13.2		12 13.2				
		Full range	11		11				
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600 \Omega$	25°C	-10.5 -13		-10.5 -13		V		
		Full range	-10		-10				
	$R_L = 2 k\Omega$	25°C	-12 -13.5		-12 -13.5				
		Full range	-11		-11				
$R_L = 1 k\Omega$	25°C	10		10		V/ μV			
	Full range	1.8		2.2					
	$V_O = \pm 10$ V, $R_L = 600 \Omega$	25°C	2 19		5 19				
		Full range	5.6		5				
c_i Input capacitance		25°C	8		8		pF		
z_o Open-loop output impedance	$I_O = 0$	25°C	50		50		Ω		
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, R_S = 50 \Omega$	25°C	100 131		117 131		dB		
		Full range	96		113				
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 4$ V to ± 18 V, $R_S = 50 \Omega$	25°C	94 144		110 144		dB		
		Full range	90		105				
I_{CC} Supply current	$V_O = 0, \text{ No load}$	25°C	3.8 5.3		3.8 4.7		mA		
		Full range	5.6		5				

*On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

† Full range is $-55^\circ C$ to $125^\circ C$.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ C$ extrapolated to $T_A = 25^\circ C$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



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operating characteristics at specified free-air temperature, $V_{CC\pm} = \pm 15\text{ V}$

PARAMETER	TEST CONDITIONS	T_A †	TLE2037M			TLE2037AM			UNIT	
			MIN	TYP	MAX	MIN	TYP	MAX		
SR	Slew rate	$A_{VD} = 5,$ $C_L = 100\text{ pF},$ See Figure 1	25°C	6*	7.5		6*	7.5	V/ μ s	
			Full range	4.4*			4.4*			
V_n	Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega,$ $f = 10\text{ Hz}$	25°C		3.3	8*		3.3	4.5*	nV/ $\sqrt{\text{Hz}}$
					2.5	4.5*		2.5	3.8*	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1\text{ Hz to }10\text{ Hz}$	25°C		50	250*		50	130*	nV
I_n	Equivalent input noise current	$f = 10\text{ Hz}$	25°C		1.5	4*		1.5	4*	pA/ $\sqrt{\text{Hz}}$
		$f = 1\text{ kHz}$			0.4	0.6*		0.4	0.6*	
THD	Total harmonic distortion	$V_O = \pm 10\text{ V},$ See Note 5	25°C	< 0.002%			< 0.002%			
	Gain-bandwidth product	$f = 100\text{ kHz},$ $C_L = 100\text{ pF}$	25°C	35	50		35	50		MHz
B_{OM}	Maximum output-swing bandwidth	$R_L = 2\text{ k}\Omega$	25°C		80			80		kHz
ϕ_m	Phase margin	$R_L = 2\text{ k}\Omega,$ $C_L = 100\text{ pF}$	25°C		50°			50°		

*On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

† Full range is – 55°C to 125°C.

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.

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electrical characteristics, $V_{CC\pm} = \pm 15\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TLE2037Y			UNIT
		MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0$, $R_S = 50\ \Omega$	20	100		μV
Input offset voltage long-term drift (see Note 4)		0.006	1		$\mu\text{V}/\text{mo}$
I_{IO} Input offset current		6	90		nA
I_{IB} Input bias current		15	90		nA
V_{ICR} Common-mode input voltage range	$R_S = 50\ \Omega$	-11 to 11	-13 to 13		V
V_{OM+} Maximum positive peak output voltage swing	$R_L = 600\ \Omega$	10.5	12.9		V
	$R_L = 2\ \text{k}\Omega$	12	13.2		
V_{OM-} Maximum negative peak output voltage swing	$R_L = 600\ \Omega$	-10.5	-13		V
	$R_L = 2\ \text{k}\Omega$	-12	-13.5		
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 11\ \text{V}$, $R_L = 2\ \text{k}\Omega$	5	45		V/ μV
	$V_O = \pm 10\ \text{V}$, $R_L = 1\ \text{k}\Omega$	3.5	38		
	$V_O = \pm 10\ \text{V}$, $R_L = 600\ \Omega$	2	19		
C_i Input capacitance			8		pF
z_o Open-loop output impedance	$I_O = 0$		50		Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $R_S = 50\ \Omega$	100	131		dB
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm} = \pm 4\ \text{V}$ to $\pm 18\ \text{V}$, $R_S = 50\ \Omega$	94	144		dB
I_{CC} Supply current	$V_O = 0$, No load	3.8	5.3		mA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated to $T_A = 25^\circ\text{C}$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.

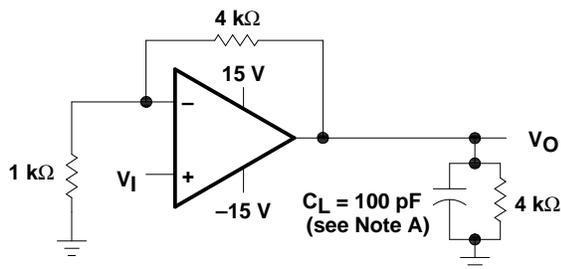
operating characteristics, $V_{CC\pm} = \pm 15\ \text{V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TLE3027Y			UNIT
		MIN	TYP	MAX	
SR Slew rate	$A_{VD} = 5$, See Figure 1 $R_L = 2\ \text{k}\Omega$, $C_L = 100\ \text{pF}$,	6	7.5		V/ μs
V_n Equivalent input noise voltage (see Figure 2)	$R_S = 20\ \Omega$, $f = 10\ \text{Hz}$		3.3	8	nV/ $\sqrt{\text{Hz}}$
	$R_S = 20\ \Omega$, $f = 1\ \text{kHz}$		2.5	4.5	
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0.1\ \text{Hz}$ to $10\ \text{Hz}$		50	250	nV
I_n Equivalent input noise current	$f = 10\ \text{Hz}$		1.5	4	pA/ $\sqrt{\text{Hz}}$
	$f = 1\ \text{kHz}$		0.4	0.6	
THD Total harmonic distortion	$V_O = \pm 10\ \text{V}$, $A_{VD} = 5$, See Note 5		< 0.002%		
Gain-bandwidth product	$f = 100\ \text{kHz}$, $R_L = 2\ \text{k}\Omega$, $C_L = 100\ \text{pF}$	35	50		MHz
B_{OM} Maximum output-swing bandwidth	$R_L = 2\ \text{k}\Omega$		80		kHz
ϕ_m Phase margin	$R_L = 2\ \text{k}\Omega$, $C_L = 100\ \text{pF}$		50°		

NOTE 5: Measured distortion of the source used in the analysis was 0.002%.



PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes fixture capacitance.

Figure 1. Slew-Rate Test Circuit

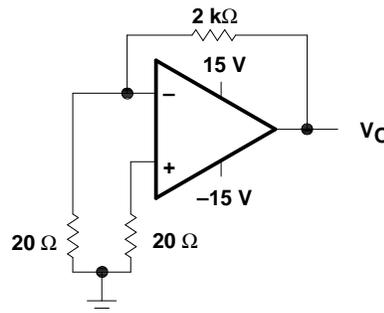


Figure 2. Noise-Voltage Test Circuit

typical values

Typical values as presented in this data sheet represent the median (50% point) of device parametric performance.

initial estimates of parameter distributions

In the on-going program of improving data sheets and supplying more information to our customer, Texas Instruments has added an estimate of not only the typical values but also the spread around these values. These are in the form of distribution bars that show the 95% (upper) points and the 5% (lower) points from our characterization of the initial wafer lots of this new device type (see Figure 3). The distribution bars are shown at the points where data was actually collected. The 95% and 5% points are used instead of ± 3 sigma since some of the distributions are not true Gaussian distributions.

The number of units tested and the number of different wafer lots used are on all of the graphs where distribution bars are shown. As noted in Figure 3, there were a total of 835 units from 2 wafer lots. In this case, there is a very good estimate for the within-lot variability and a possibly poor estimate of the lot-to-lot variability. This will always be the case on newly released products, since there will only be data available from a few wafer lots.

The distribution bars are not intended to replace the minimum and maximum limits in the electrical tables. Each distribution bar represents 90% of the total units tested at a specific temperature. And, while 10% of the units tested fell outside any given distribution bar, this should not be interpreted to mean that the same individual devices fell outside every distribution bar.

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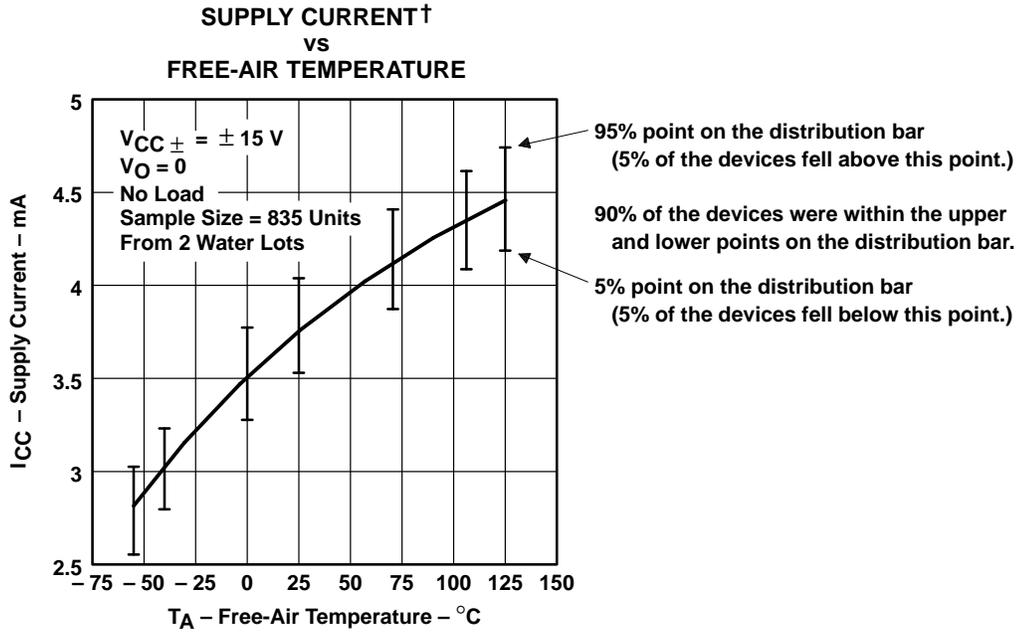


Figure 3. Sample Graph With Distribution Bars

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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Table of Graphs

			FIGURE
V_{IO}	Input offset voltage	Distribution	4
ΔV_{IO}	Input offset voltage change	vs Time after power on	5,6
I_{IO}	Input offset current	vs Free-air temperature	7
I_{IB}	Input bias current	vs Common-mode input voltage	8
		vs Free-air temperature	9
I_I	Input current	vs Differential input voltage	10
$V_{O(PP)}$	Maximum peak-to-peak output voltage	vs Frequency	11
V_{OM}	Maximum peak output voltage	vs Load resistance	12,13
		vs Free-air temperature	14,15
A_{VD}	Large-signal differential voltage amplification	vs Supply voltage	16
		vs Load resistance	17
		vs Frequency	18,19
		vs Free-air temperature	20
z_o	Output impedance	vs Frequency	21
CMRR	Common-mode rejection ratio	vs Frequency	22
k_{SVR}	Supply voltage rejection ratio	vs Frequency	23
I_{OS}	Short-circuit output current	vs Supply voltage	24, 25
		vs Time	26, 27
		vs Free-air temperature	28, 29
I_{CC}	Supply current	vs Supply voltage	30
		vs Free-air temperature	31
	Pulse response	Small signal	32
		Large signal	33
V_n	Equivalent input noise voltage	vs Frequency	34
	Noise voltage (referred to input)	0.1 to 10 Hz	35
	Gain-bandwidth product	vs Supply voltage	36
		vs Load capacitance	37
SR	Slew rate	vs Free-air temperature	38
ϕ_m	Phase margin	vs Supply voltage	39
		vs Load capacitance	40
		vs Free-air temperature	41
	Phase shift	vs Frequency	18, 19

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TYPICAL CHARACTERISTICS†

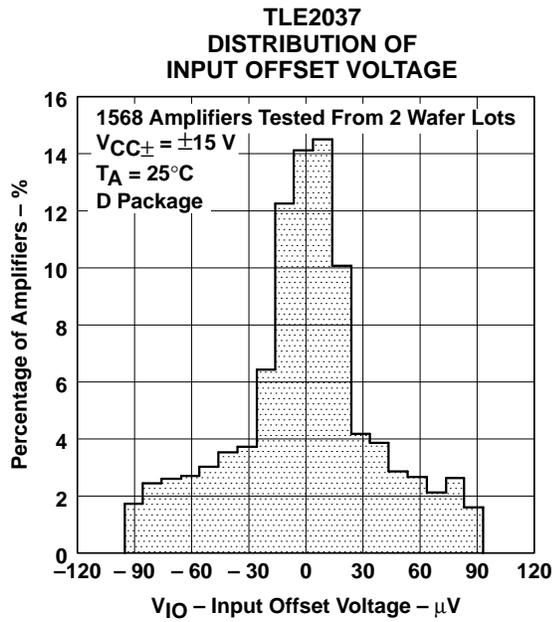


Figure 4

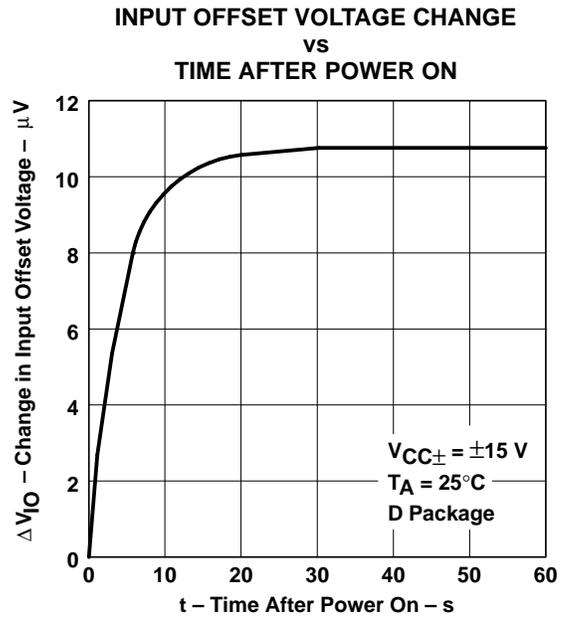


Figure 5

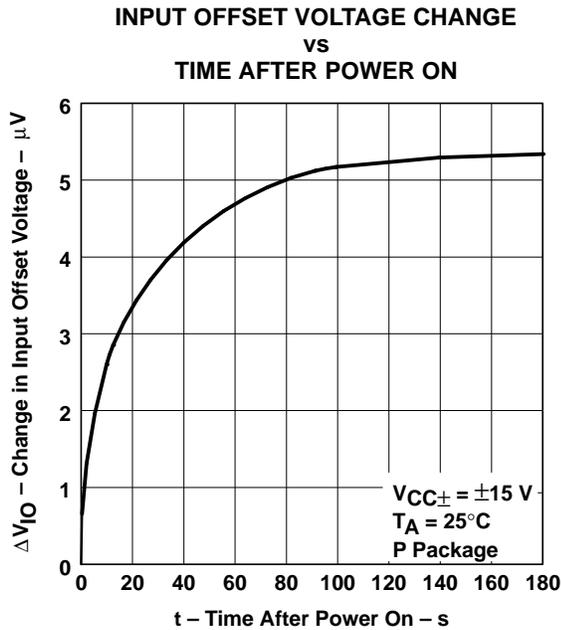


Figure 6

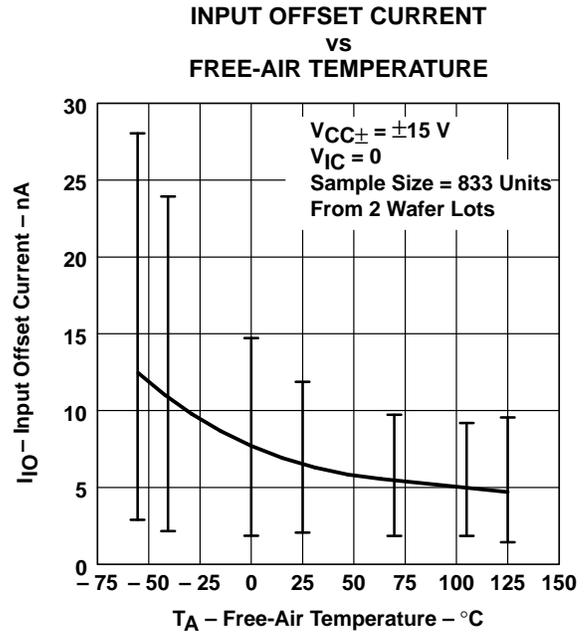
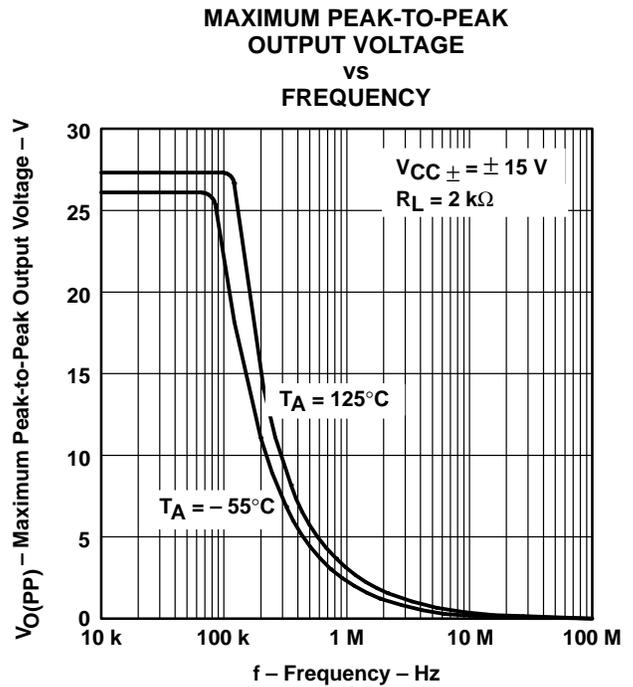
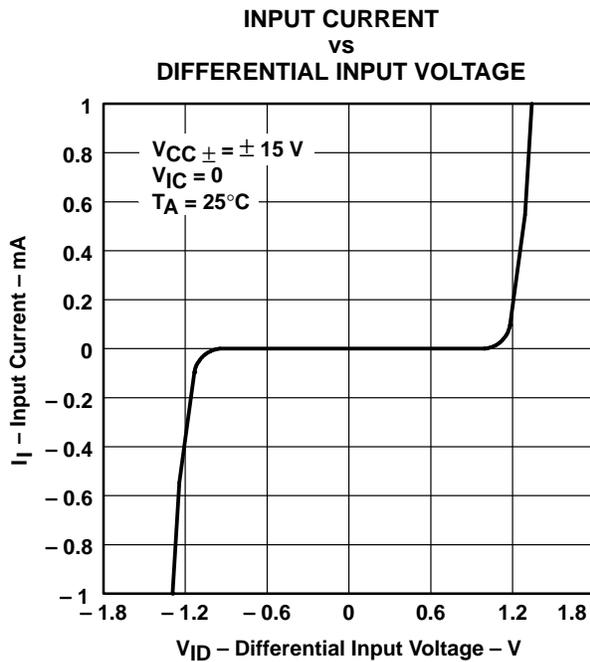
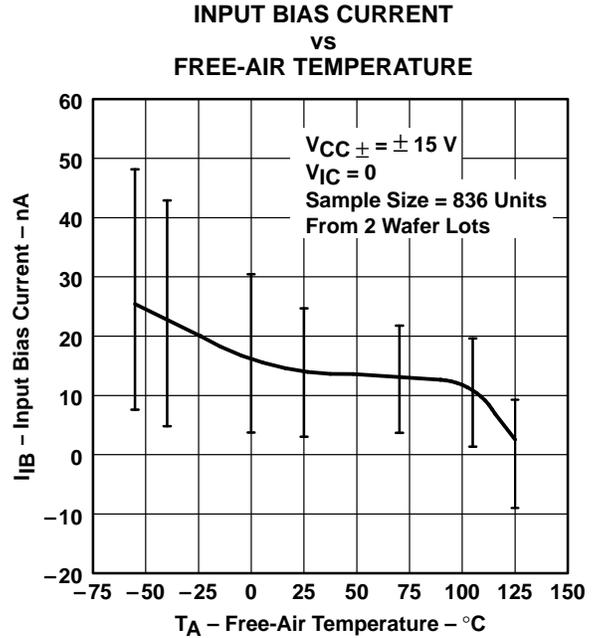
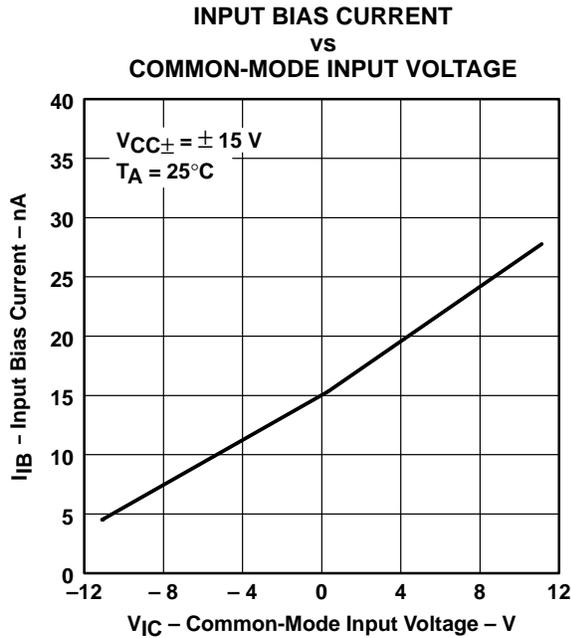


Figure 7

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS†



† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS†

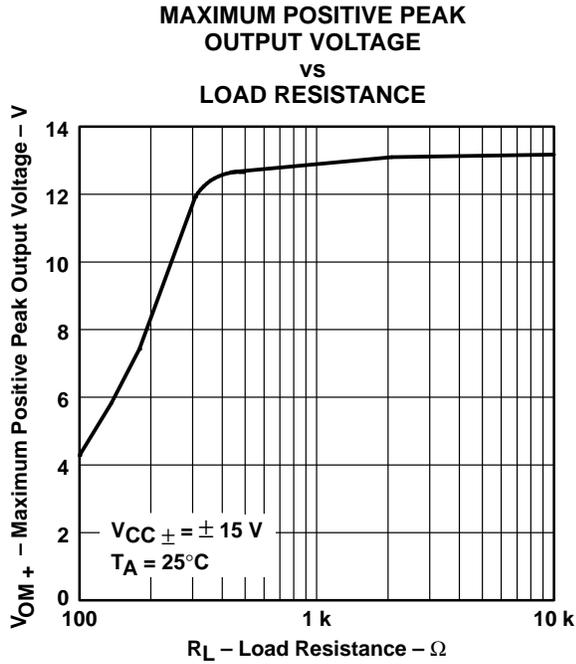


Figure 12

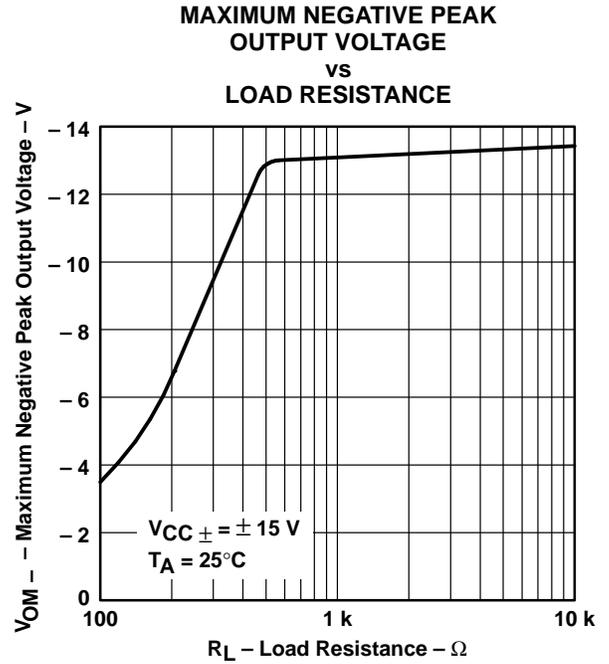


Figure 13

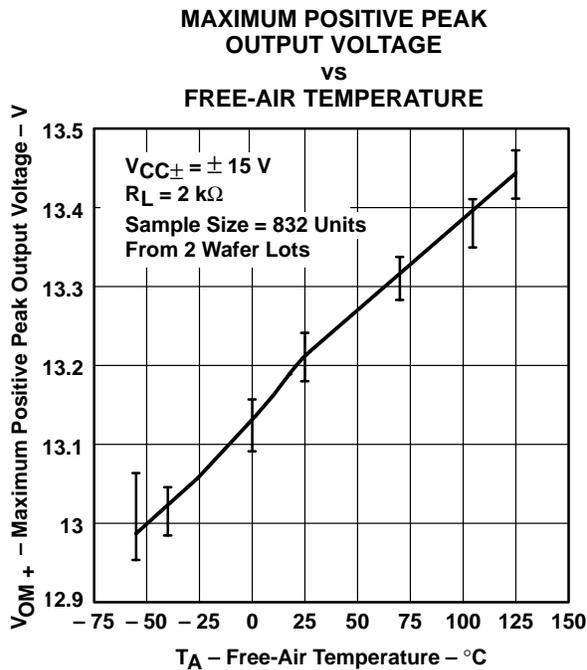


Figure 14

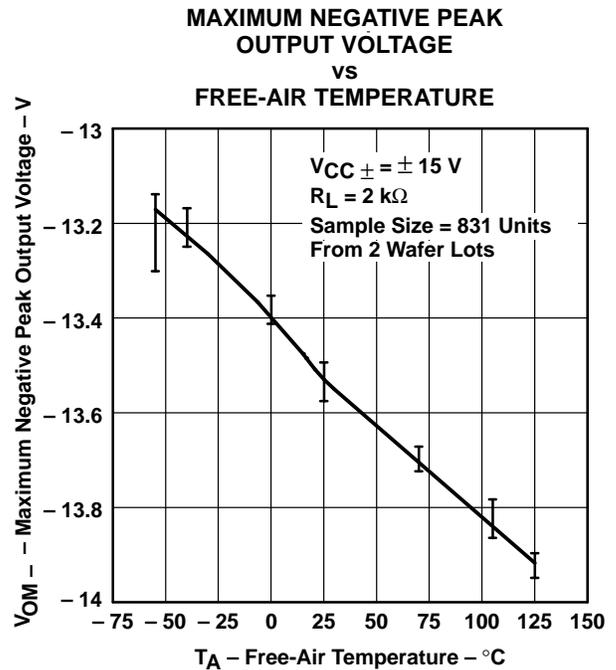


Figure 15

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

LARGE-SIGNAL DIFFERENTIAL
 VOLTAGE AMPLIFICATION
 VS
 SUPPLY VOLTAGE

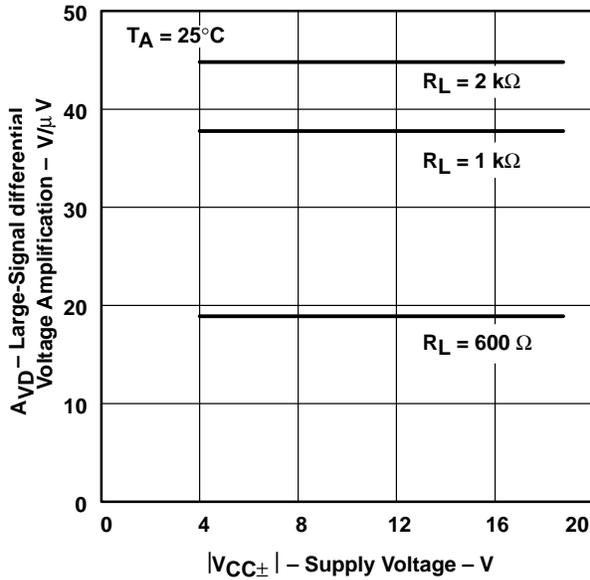


Figure 16

LARGE-SIGNAL VOLTAGE AMPLIFICATION
 VS
 LOAD RESISTANCE

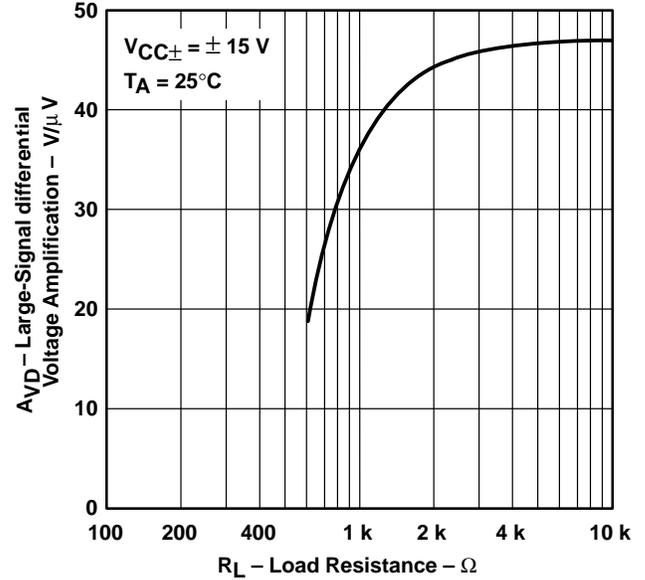


Figure 17

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
 AMPLIFICATION AND PHASE SHIFT
 VS
 FREQUENCY

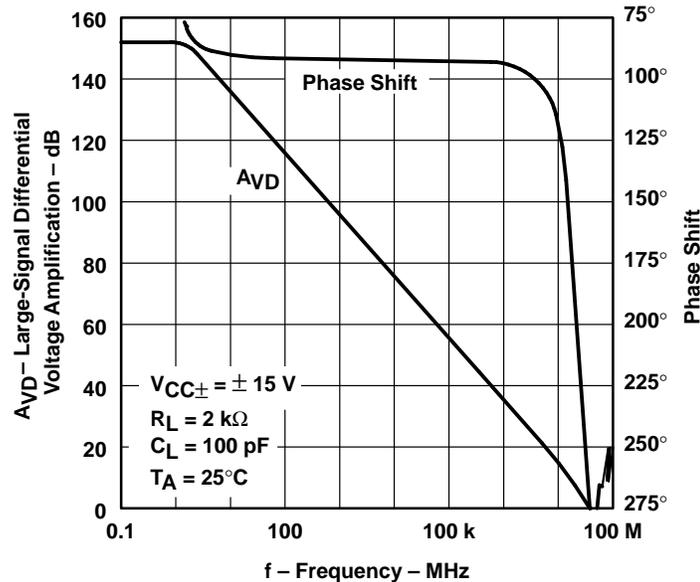


Figure 18

TLE2037, TLE2037A, TLE2037Y
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TYPICAL CHARACTERISTICS†

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
 AMPLIFICATION AND PHASE SHIFT
 vs
 FREQUENCY

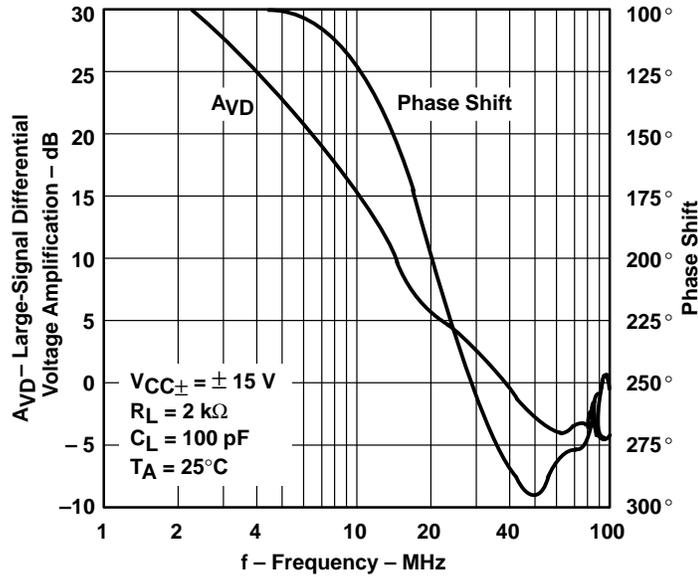


Figure 19

LARGE-SIGNAL DIFFERENTIAL
 VOLTAGE AMPLIFICATION
 vs
 FREE-AIR TEMPERATURE

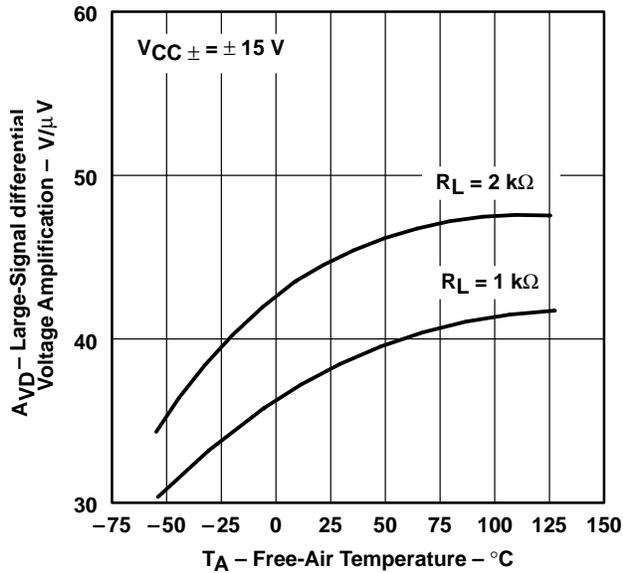


Figure 20

OUTPUT IMPEDANCE
 vs
 FREQUENCY

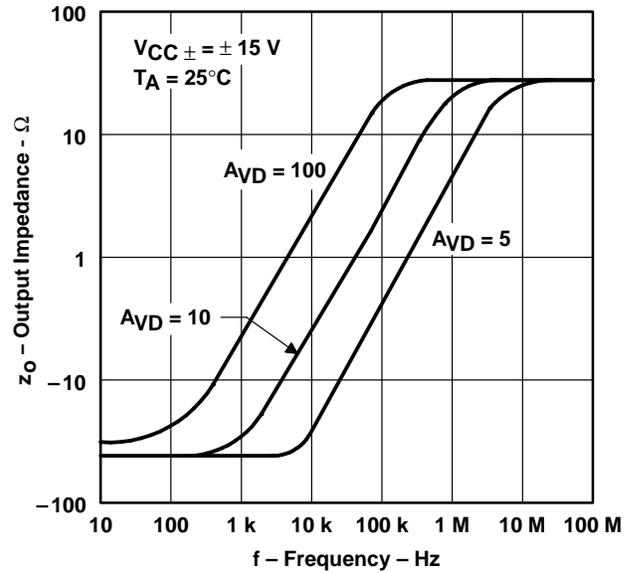


Figure 21

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

COMMON-MODE REJECTION RATIO
 vs
 FREQUENCY

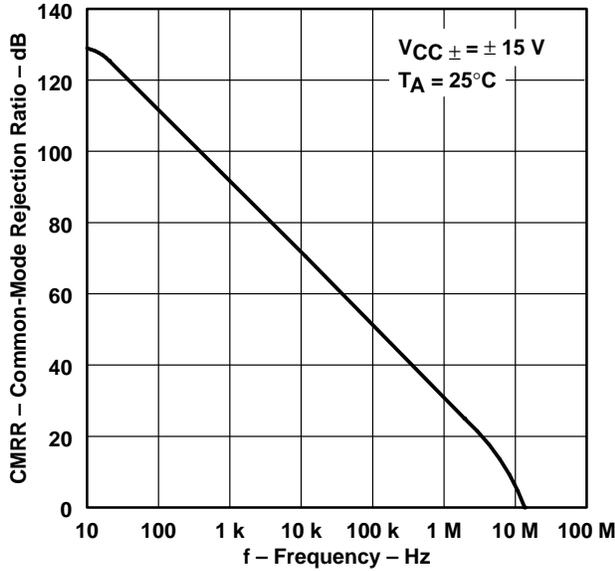


Figure 22

SUPPLY-VOLTAGE REJECTION RATIO
 vs
 FREQUENCY

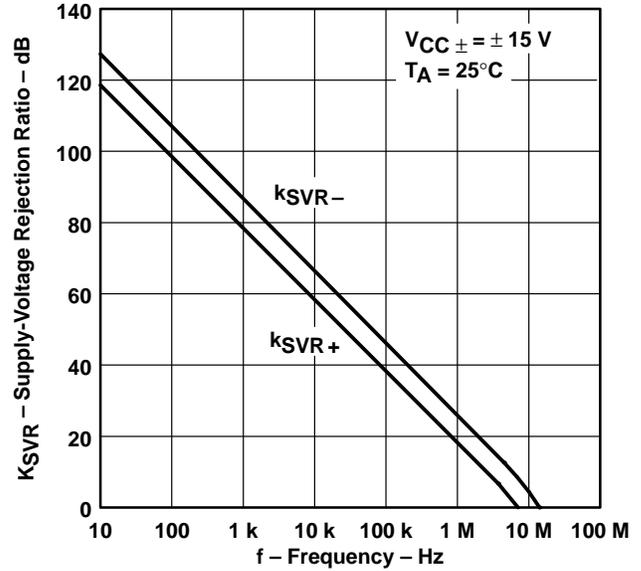


Figure 23

SHORT-CIRCUIT OUTPUT CURRENT
 vs
 SUPPLY VOLTAGE

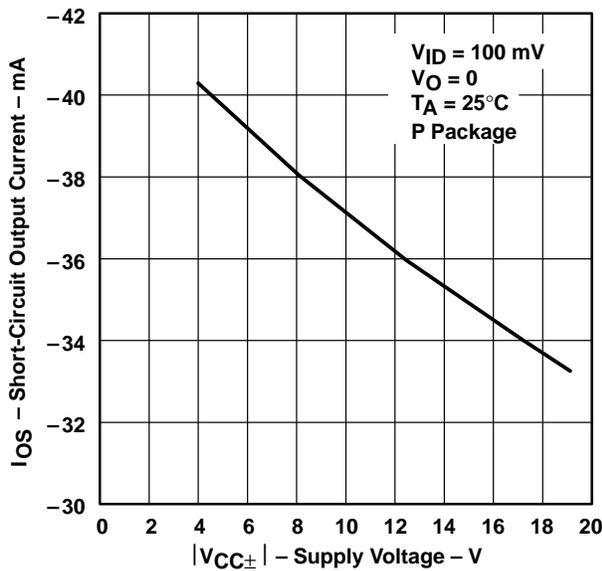


Figure 24

SHORT-CIRCUIT OUTPUT CURRENT
 vs
 SUPPLY VOLTAGE

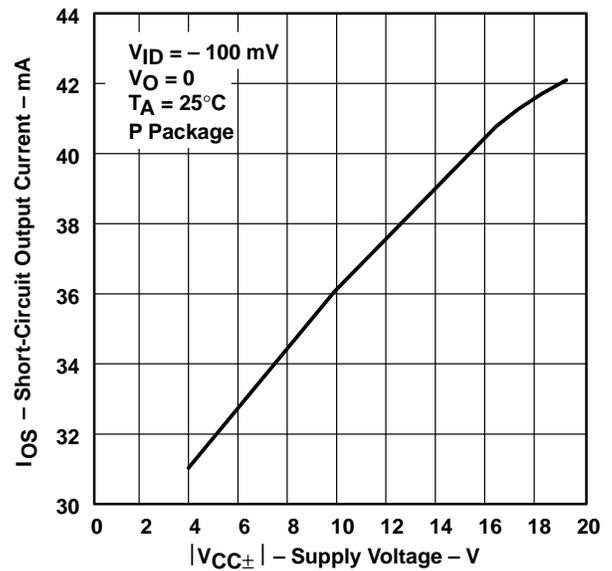
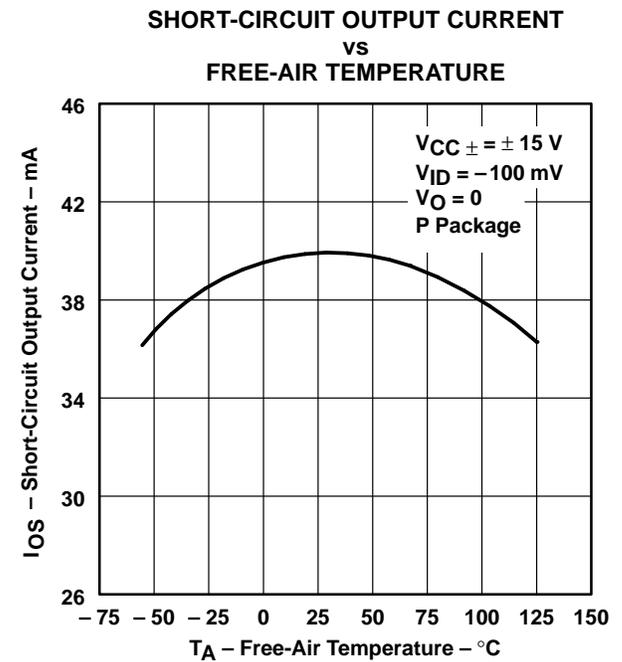
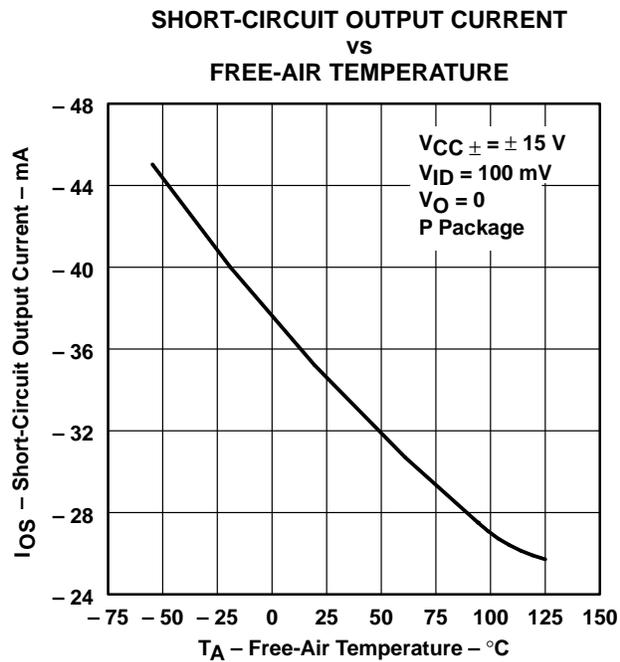
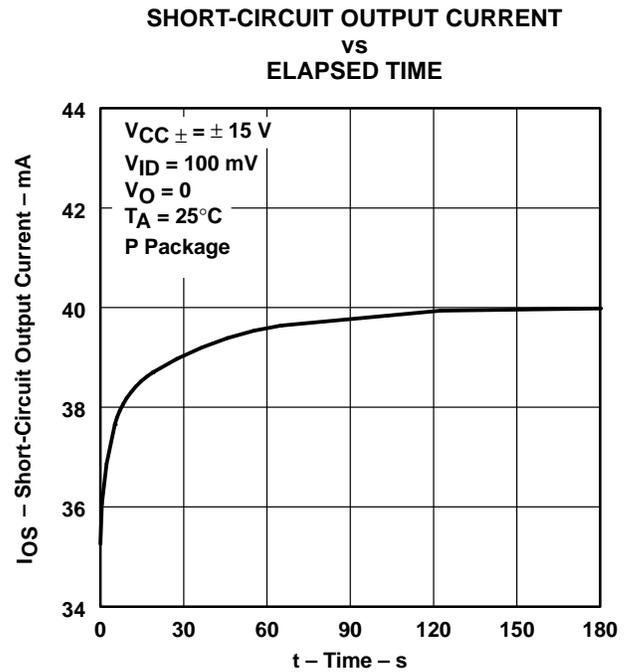
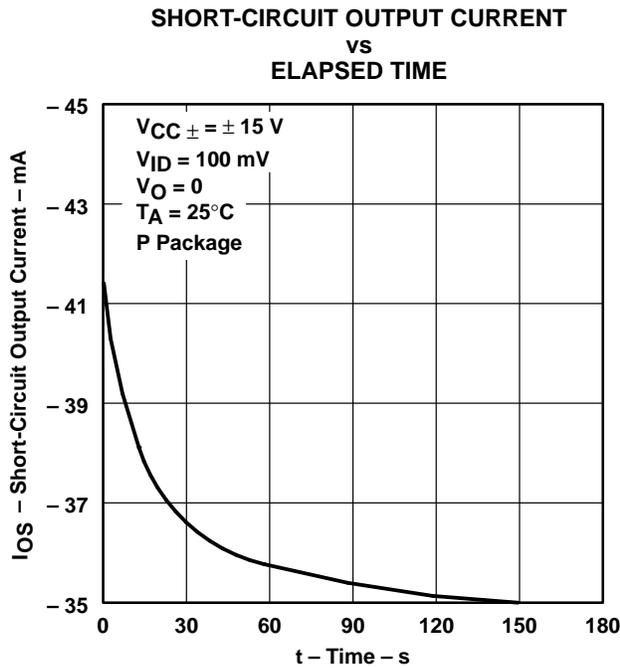


Figure 25

TLE2037, TLE2037A, TLE2037Y
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† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS†

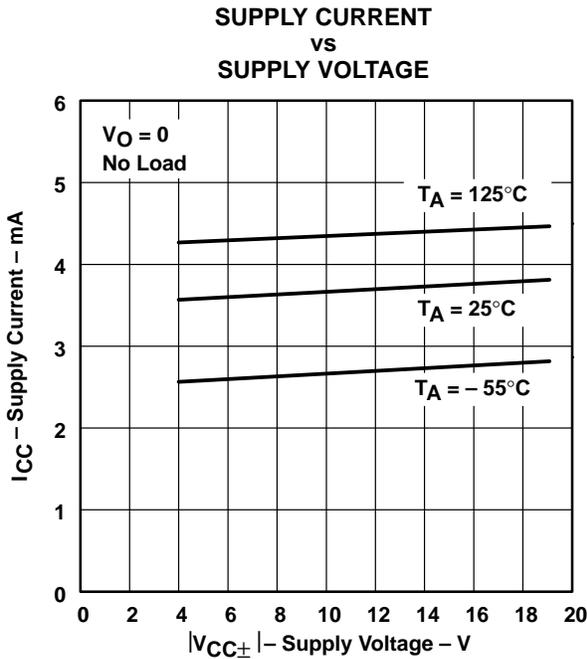


Figure 30

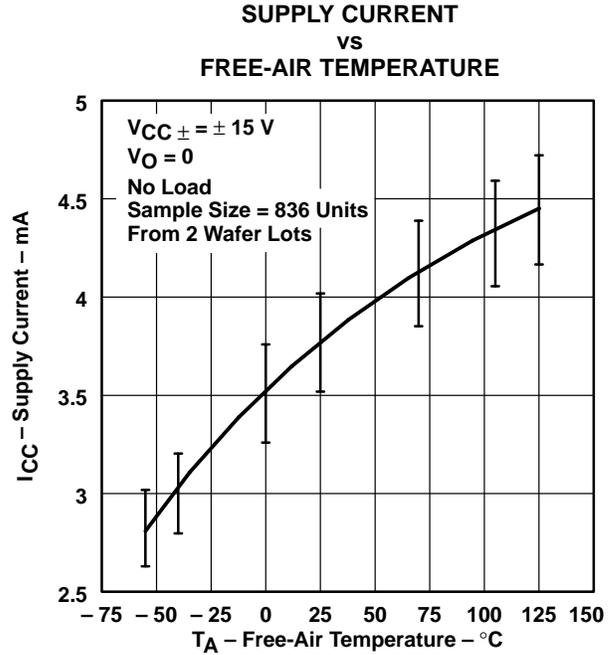


Figure 31

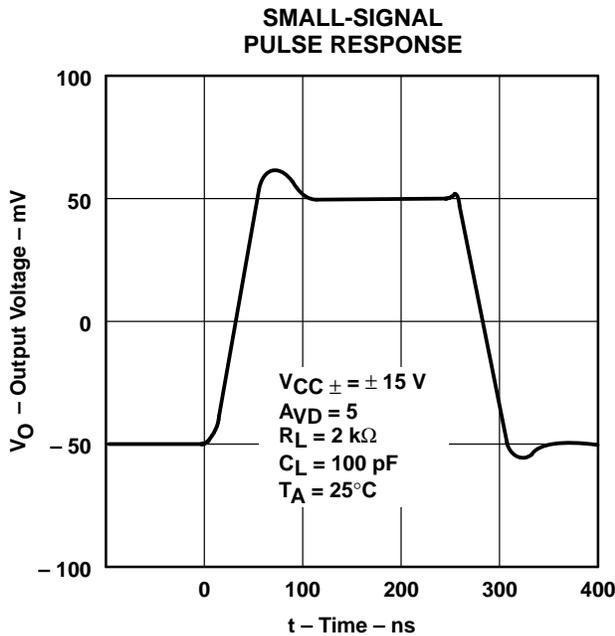


Figure 32

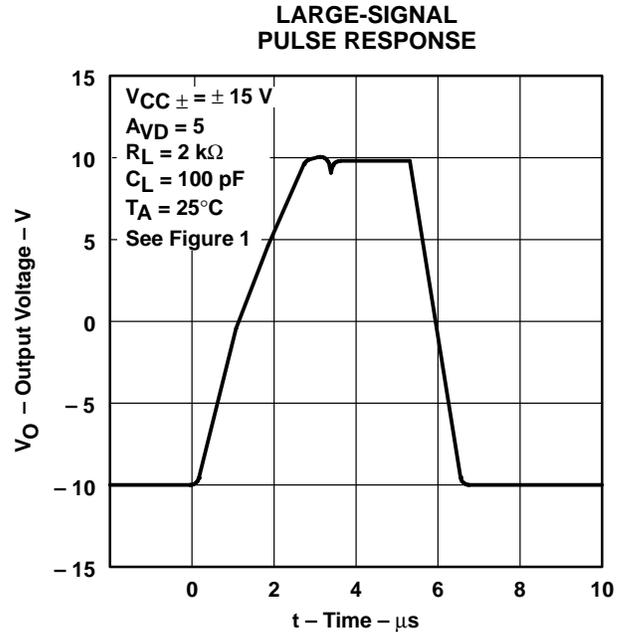


Figure 33

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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**EQUIVALENT INPUT NOISE VOLTAGE
 vs
 FREQUENCY**

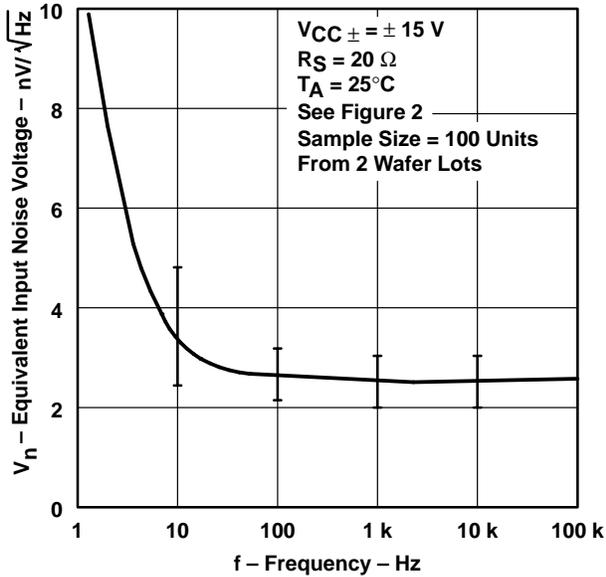


Figure 34

**NOISE VOLTAGE
 (REFERRED TO INPUT)
 OVER A 10-SECOND INTERVAL**

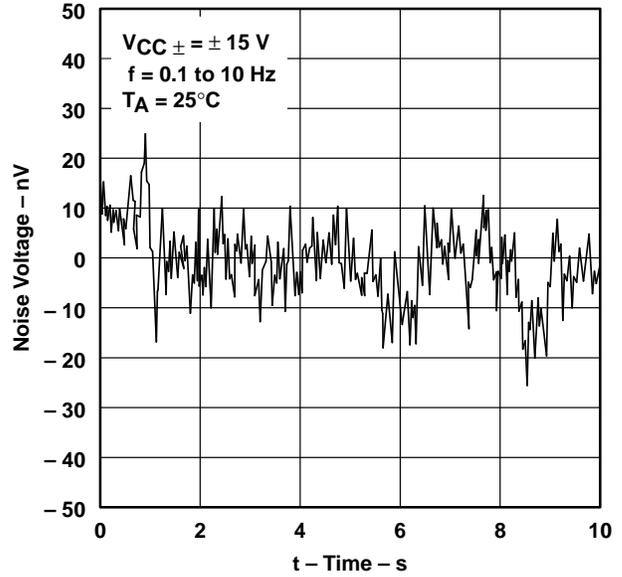


Figure 35

**GAIN-BANDWIDTH PRODUCT
 vs
 SUPPLY VOLTAGE**

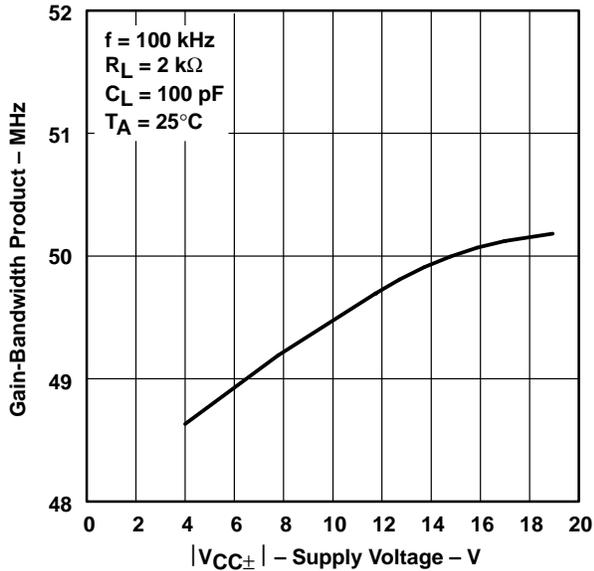


Figure 36

**GAIN-BANDWIDTH PRODUCT
 vs
 LOAD CAPACITANCE**

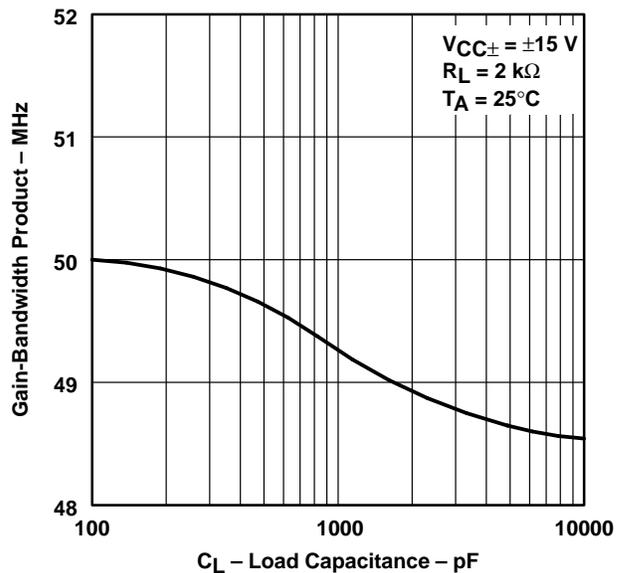


Figure 37

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS†

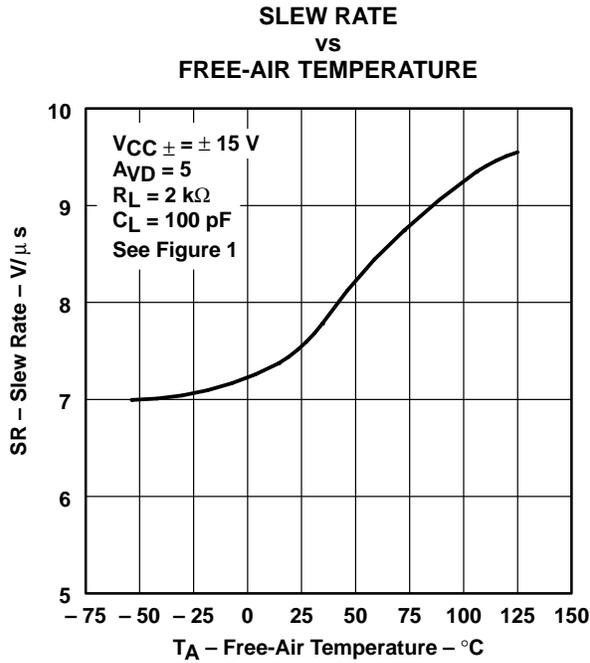


Figure 38

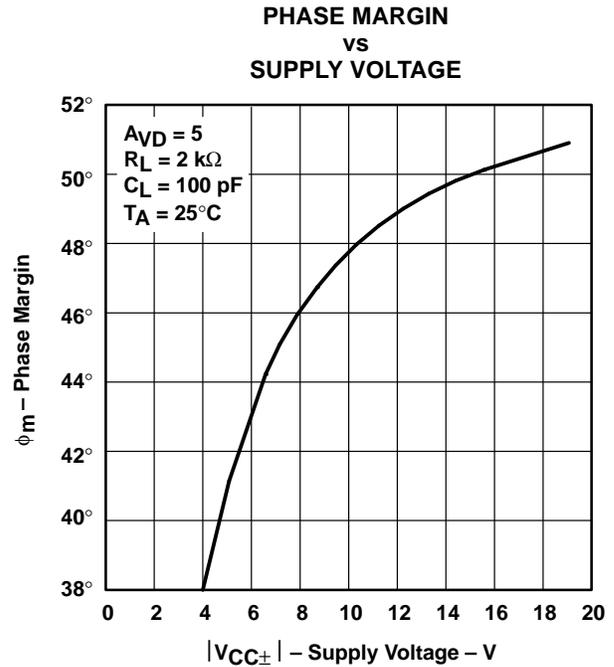


Figure 39

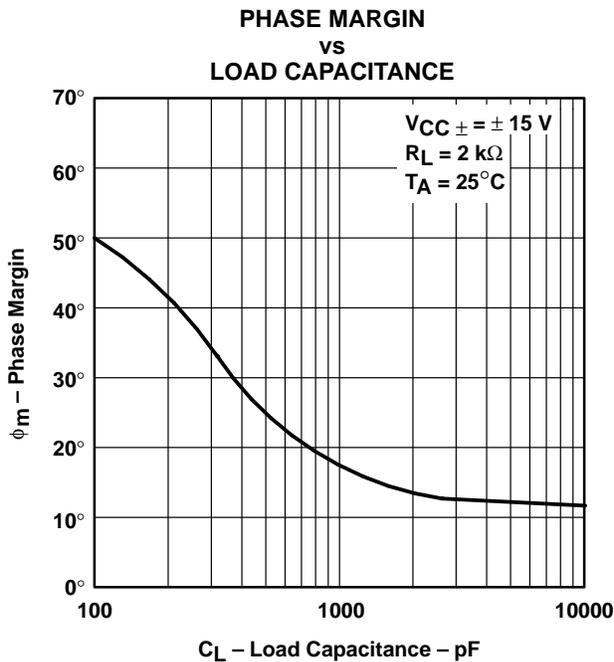


Figure 40

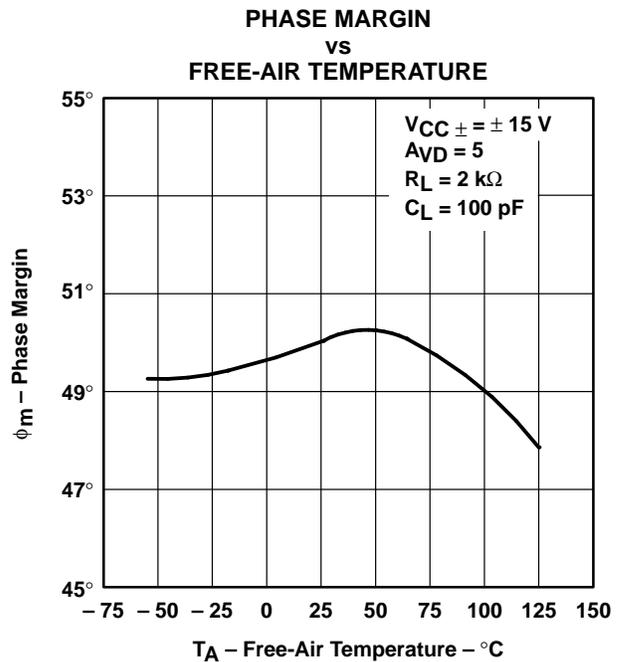


Figure 41

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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APPLICATION INFORMATION

input offset voltage nulling

The TLE2037 series offers external null pins that can be used to further reduce the input offset voltage. The circuits of Figure 42 can be connected as shown if the feature is desired. If external nulling is not needed, the null pins may be left disconnected.

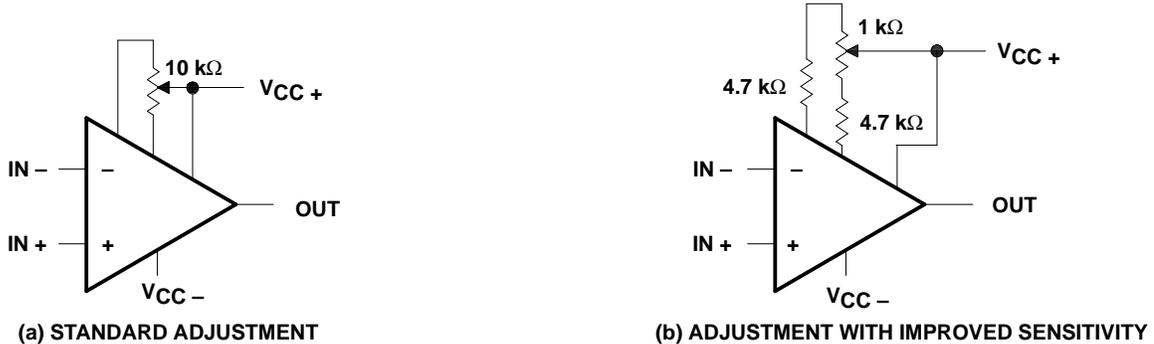


Figure 42. Input Offset Voltage Nulling Circuits

macromodel information

Macromodel information provided was derived using *PSpice™ Parts™* model generation software. The Boyle macromodel (see Note 6) and subcircuit in Figures 42 and 43 were generated using the TLE2037 typical electrical and operating characteristics at 25°C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification
- Gain-bandwidth product
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 6: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", IEEE Journal of Solid-State Circuits, SC-9, 353 (1974).

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 **TEXAS
INSTRUMENTS**

APPLICATION INFORMATION

macromodel information (continued)

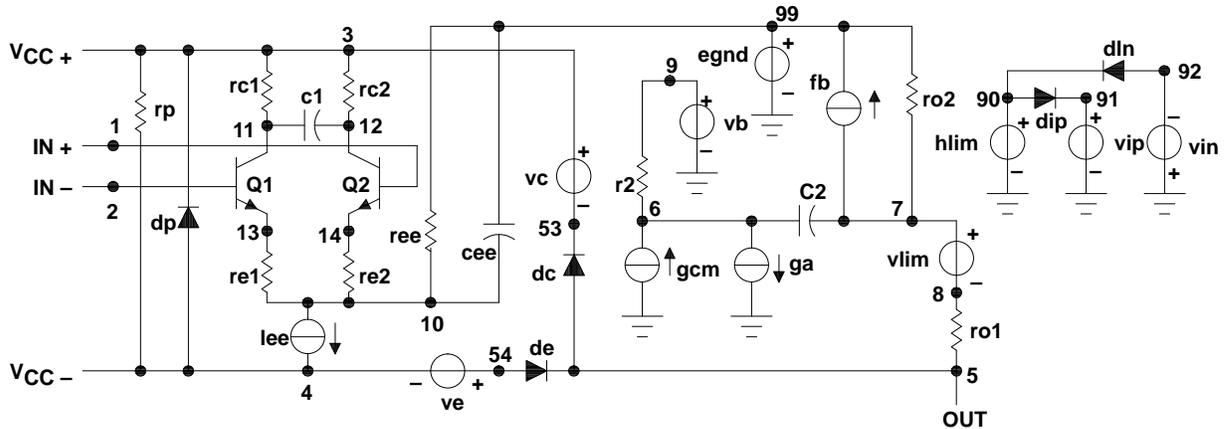


Figure 43. Boyle Macromodel

```
.subckt TLE2037 1 2 3 4 5
*
c1      11  12  4.003E-12
c2      6   7   7.500E-12
dc      5   53  dz
de      54  5   dz
dlp     90  91  dz
dln     92  90  dx
dp      4   3   dz
egnd    99  0   poly(2) (3,0) (4,0) 0 .5 .5
fb      7   99  poly(5) vb vc ve vip vln 0 923.4E6 A800E6 800E6 800E6 A800E6
ga      6   0  11  12  2.121E-3
gcm     0   6  10  99  597.7E-12
iee     10  4   dc  56.26E-6
hlim    90  0   vlim 1K
q1      11  2  13  qx
q2      12  1  14  qz
r2      6   9   100.0E3
rc1     3   11  471.5
rc2     3   12  471.5
re1     13  10  A448
re2     14  10  A448
ree     10  99  3.555E6
ro1     8   5   25
ro2     7   99  25
rp      3   4   8.013E3
vb      9   0   dc  0
vc      3   53  dc  2.400
ve      54  4   dc  2.100
vlim    7   8   dc  0
vlp     91  0   dc  40
vln     0   92  dc  40
.model  dx D(Is=800.0E-18)
.model  qx NPN(Is=800.0E-18 Bf=7.031E3)
.ends
```

Figure 44. Macromodel Subcircuit

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